

Search Notes**Application/Control No.**

10/734,160

Examiner

HUYEN X. VO

**Applicant(s)/Patent under
Reexamination**

KIM ET AL.

Art Unit

2626

SEARCHED

Class	Subclass	Date	Examiner
704	500; 501; 502; 503; 504	1/26/2010	HV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Update EAST search included	1/26/2010	HV